

Search Notes**Application/Control No.**

10/774,306

Examiner

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Applicant(s)/Patent under Reexamination

DE JONG ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	229	6/13/2007	NFD
370	235	6/13/2007	NFD
370	236	6/13/2007	NFD
370	328	6/13/2007	NFD
370	329	6/13/2007	NFD
370	349	6/13/2007	NFD

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (see attached search history)	6/13/2007	NFD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner